

Api	licatio	n/Contro	I No.

Applicant(s)/Patent under Reexamination

10/015,613

BAUDISCH, PATRICK
Art Unit

Examiner

Aaron M. Richer

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) - See Search History Printout	3/1/2006	AMR		
345/1.3 (text search only)	3/1/2006	AMR		
Updated	11/19/2006	AMR		
Updated	6/13/2007	AMR		
Updated	1/15/2008	AMR		
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